

<b>Notice of References Cited</b>	Application/Control No. 10/066,766	Applicant(s)/Patent Under Reexamination TAKANO ET AL.	
	Examiner TAN TRINH	Art Unit 2684	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2002/0132628 A1	09-2002	Matsumoto et al.	455/456
*	C	US-2002/0145991 A1	10-2002	Miya et al.	370/337
*	D	US-5,682,602	10-1997	Walker et al.	455/436
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**NON-PATENT DOCUMENTS**

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